

Description

The VSM14N02 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

V_{DS} =20V,I_D =14A

 $R_{DS(ON)}$ <7 m Ω @ V_{GS} =4.5V

 $R_{DS(ON)}$ <9 m Ω @ V_{GS} =2.5V

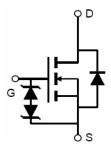
ESD Rating: 2000V HBM

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- PWM application
- Load switch





SOP-8

Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM14N02-S8	VSM14N02	SOP-8	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	20	V	
Gate-Source Voltage	V _G s	±10	V	
Drain Current-Continuous	I _D	14	А	
Pulsed Drain Current	I _{DM}	44	А	
Maximum Power Dissipation	P _D	3	W	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}\!\mathbb{C}$	

Thermal Characteristic

Thermal Resistance,Junction-to-Ambient ^(Note 2)	$R_{ heta JA}$	42	°C/W



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Electrical Characteristics (T_A=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	20	22	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =20V,V _{GS} =0V	-	-	1	μA	
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±10V,V _{DS} =0V	-	-	±10	μA	
On Characteristics (Note 3)	·						
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	0.6	0.8	1.2	V	
Dunin Course On State Besistence	Б	V _{GS} =4.5V, I _D =10A	-	5	7	mΩ	
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =2.5V, I _D =5.5A	-	7	9		
Forward Transconductance	g FS	V _{DS} =5V,I _D =10A	30	-	-	S	
Dynamic Characteristics (Note4)			•				
Input Capacitance	C _{Iss}	V _{DS} =10V,V _{GS} =0V,	-	1710	-	PF	
Output Capacitance	C _{oss}		-	232	-	PF	
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz	-	200	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t _{d(on)}		-	2.5	-	nS	
Turn-on Rise Time	t _r	V_{DD} =10V, R_L =1 Ω	-	7.2	-	nS	
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10 V , R_{GEN} =3 Ω	-	49	-	nS	
Turn-Off Fall Time	t _f		-	10.8	-	nS	
Total Gate Charge	Qg	\/ 40\/ L 40^	-	17.5	-	nC	
Gate-Source Charge	Q _{gs}	V_{DS} =10V, I_{D} =10A, V_{GS} =4.5V	-	1.5	-	nC	
Gate-Drain Charge	Q _{gd}	V _{GS} -4.5V	-	4.5	-	nC	
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =10A	-	-	1.2	V	
Diode Forward Current (Note 2)	Is		-	-	14	А	

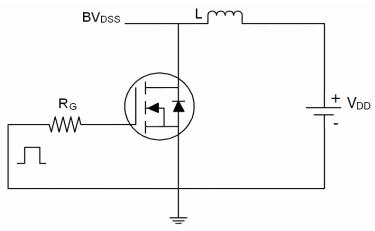
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

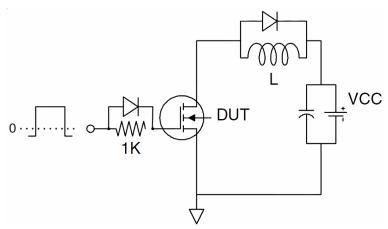


Test Circuit

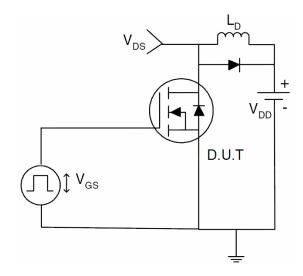
1) E_{AS} test Circuits



2) Gate charge test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics

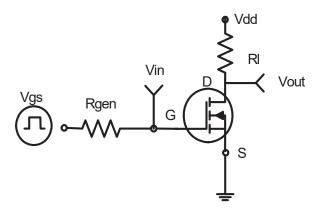


Figure 1:Switching Test Circuit

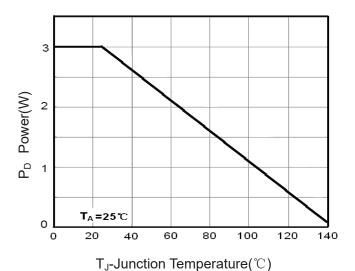


Figure 3 Power Dissipation

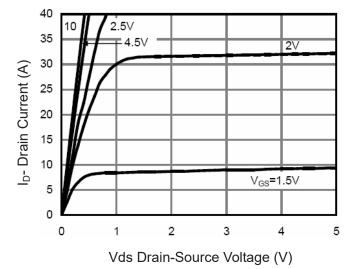


Figure 5 Output Characteristics

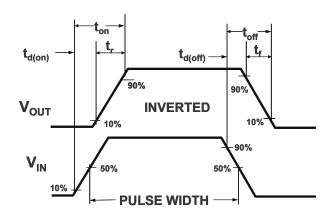


Figure 2:Switching Waveforms

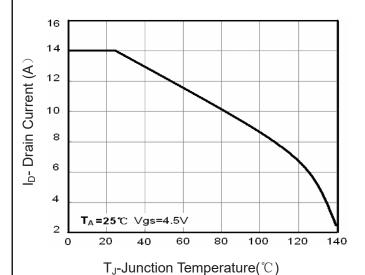


Figure 4 Drain Current

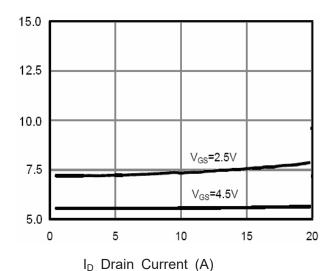


Figure 6 Drain-Source On-Resistance



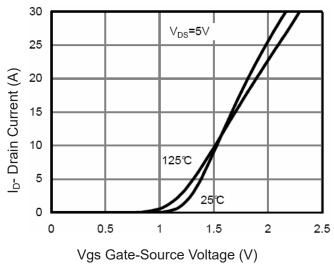


Figure 7 Transfer Characteristics

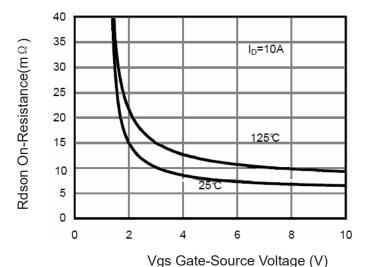


Figure 9 Rdson vs Vgs

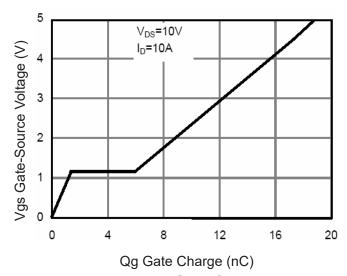


Figure 11 Gate Charge

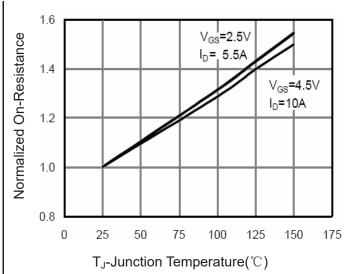


Figure 8 Drain-Source On-Resistance

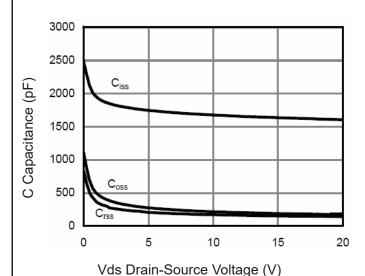


Figure 10 Capacitance vs Vds

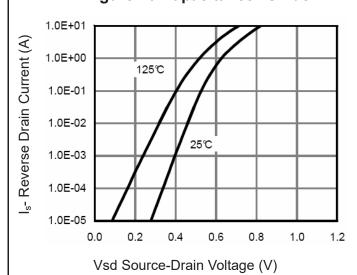


Figure 12 Source- Drain Diode Forward



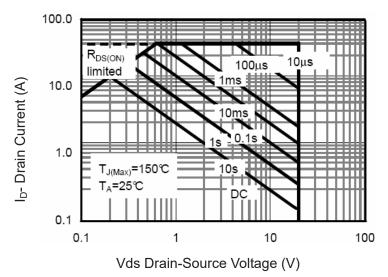


Figure 13 Safe Operation Area

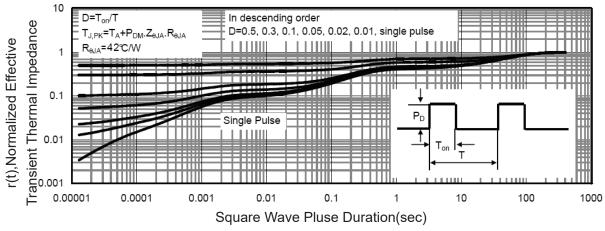


Figure 14 Normalized Maximum Transient Thermal Impedance